

<b>Notice of References Cited</b>	Application/Control No. 10/075,588	Applicant(s)/Patent Under Reexamination MATSUHASHI ET AL.	
	Examiner DuyVu n Deo	Art Unit 1765	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,331,193	07-1994	Mukogawa, Yasukazu	257/371
	B	US-2001/0019155	09-2001	WARASHINA et al.	257/351
	C	US-6,380,053	04-2002	Komatsu, Hiroshi	438/517
	D	US-6,025,629	02-2000	Ipposhi et al.	257/347
	E	US-5,218,217	06-1993	Oda et al.	257/296
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.